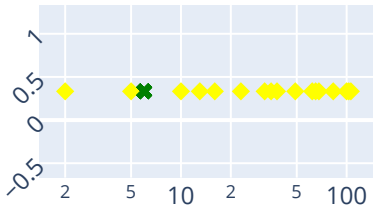


test loss

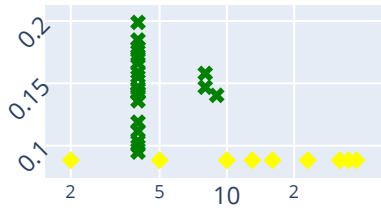
Circuit Recovery (IOI)



tracr-reverse

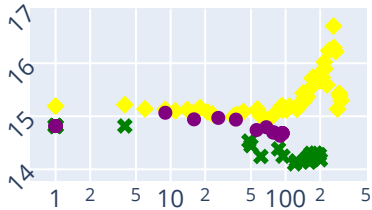


tracr-xproportion

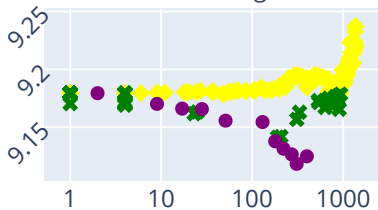


◆ HISP
✕ SP
● ACDC

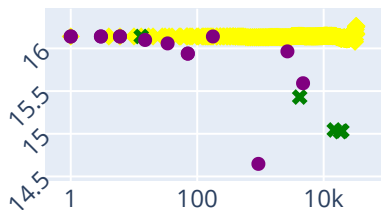
Induction



Docstring



Greater-Than



Number of edges